

# Dual Channel x1 PCle Redriver/Equalizer

Check for Samples: SN65LVPE501

# **FEATURES**

- Single Lane PCle Equalizer/Redriver
- Support for Both PCle Gen I (2.5Gbps) and Gen II (5.0 Gbps) Speed
- Selectable Equalization, De-emphasis and Output Swing Control
- Integrated Termination
- Hot-Plug Capable
- Receiver Detect
- Low Power:
  - 330mW(TYP),  $V_{CC} = 3.3V$
- Auto Low Power Modes:
  - 5mW (TYP) When no Connection Detected
  - 70mW (TYP) When in Auto-Low Power Mode

- Excellent Jitter and Loss Compensation Capability:
  - 30" of 6 mil Stripline on FR4
- Small Foot Print 24 Pin 4 x 4 QFN Package
- High Protection Against ESD Transient

HBM: 3,000 VCDM: 1,500 VMM: 200 V

#### **APPLICATIONS**

 PC MB, Docking Stations, Backplane and Cabled Application

# **DESCRIPTION**

The SN65LVPE501 is a dual channel, single lane PCIe redriver and signal conditioner supporting data rates of up to 5.0Gbps. The device complies with PCIe spec revision 2.1.

#### Programmable EQ, De-Emphasis and Amplitude Swing

The SN65LVPE501 is designed to minimize the signal degradation effects such as crosstalk and inter-symbol interference (ISI) that limits the interconnect distance between two devices. The input stage of each channel offers selectable equalization settings that can be programmed to match loss in the channel. The differential outputs provide selectable de-emphasis to compensate for the anticipated distortion PCIe signal will experience. Level of de-emphasis will depend on the length of interconnect and its characteristics. Both equalization and de-emphasis levels are controlled by the setting of signal control pins EQ1, EQ2 and DE1, DE2.

To provide additional control of signal integrity in extended backplane applications LVPE501 provides independent output amplitude control for each channel. See Table 2 for setting details.

#### **Device PowerOn**

Device initiates internal power-on reset after  $V_{CC}$  has stabilized. External reset can also be applied at anytime by toggling RST pin. External reset is recommended after every device power-up. When RST is driven high, the device samples the state of EN\_RXD, if it is set H device enters Rx.Detect state where each channel will perform Rx.Detect function (as described in PCle spec). If EN\_RXD is set L, automatic RX detect function is disabled and both channels are enabled with their termination set to  $Z_{DC\ RX}$ .

#### **Receiver Detection**

While EN\_RXD pin is H and device is not in sleep mode ( $\overline{RST}$  is H), SN65LVPE501 performs RX.Detect on both channels indefinitely until remote termination is detected on both channels. Automatic Rx detection feature can be forced off by driving EN\_RXD low. In this state both channels input termination are set to  $Z_{DC,RX}$ .



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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

# **DESCRIPTION CONTINUED**

#### Sleep (Shut\_Down) Mode

This is low power state triggered by  $\overline{RST}$  = L. In sleep mode receiver termination resistor for each of the two channels is switched to  $Z_{RX-HIGH\_IMP}$  of >50 K $\Omega$  and transmitters are pulled to Hi-Z state. Device power is reduced to <1mW (TYP). To get device out of sleep mode  $\overline{RST}$  is toggled L-H.

# **Electrical Idle Support**

A link is in an electrical idle state when the TX $\pm$  voltage is held at a steady constant value like the common mode voltage. SN65LVPE501 detects an electrical idle state when RX $\pm$  input voltage of the associated channel falls below  $V_{EID\_TH}$  min. After detection of an electrical idle state in a given channel the device asserts electrical idle state in its corresponding TX. When RX $\pm$  voltage exceeds  $V_{EID\_TH}$  max, normal device operation is restored and output starts passing input signal. Electrical idle exit and entry time is specified at  $\leq$ 6ns.

Electrical idle support is independent for each channel.

#### **Power Save Features**

The device supports three power save modes as described below.

1. Sleep (Shut Down) Mode

This mode can be enabled from any state (Rx detect or active) by driving  $\overline{RST}$  L. In this state both channels have their termination set to  $Z_{RX-HIGH\ IMP+}$  and outputs are at Hi-Z. Device power is 1mW (MAX)

2. Auto Low Power Mode

This mode is enabled when PS pin is tied H and device is in active mode. In this mode anytime  $Vin_{diff\_pp}$  falls below selected  $V_{EID\_TH}$  for a *given channel* and stays below  $V_{EID\_TH}$  for >1µs (TYP), the associated CH will enter auto low power (ALP) mode where power/CH will be reduced to <1/3<sup>rd</sup> of normal operating power/CH or about 70mW under typical voltage of 3.3V when ALP conditions are met for both channels. A CH will exit ALP mode whenever  $Vin_{diff\_pp}$  exceeds max  $V_{EID\_TH}$  for that channel. Exit latency is 30ns max. To use this mode link latency will need to account for the ALP exit time for N\_FTS. ALP mode is handled by each channel independently based on its input differential signal level. This mode can be disabled by leaving PS as NC or tying PS to GND via  $4.7k\Omega$ .

3. Cable Disconnect Mode

This mode is activated when  $\overline{RST}$  is H,  $EN_RXD = H$ , and no termination is detected by either channel. Device is in the Rx.Detect state whereby it is continuously performing Rx.Detect on both channels. In this state total power consumed by device is typically <3% of normal active power. Or <10mW (MAX).

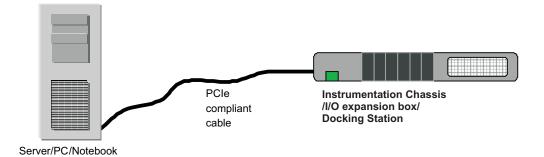
#### **Beacon Support**

With its broadband design, the SN65LVPE501 supports low frequency Beacon signal (as defined by PCIe 2.1 spec) used to indicate wake-up event to the system by a downstream device when in L2 power state. All requirements for a beacon signal as specified in PCI Express specification 2.1 must be met for device to pass beacon signals.

#### **Devic Power**

The SN65LVPE501 is designed to operate from a single 3.3V supply. Always practice proper supply sequencing procedure. Apply  $V_{CC}$  first before any input control pin signals are applied to the device. Power-down sequence is in reverse order.





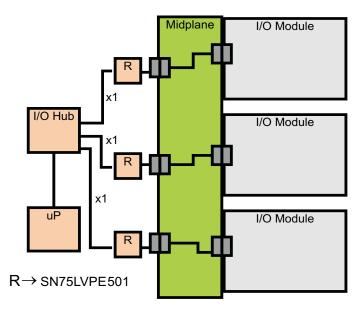


Figure 1. SN65LVPE501 Typical Applications



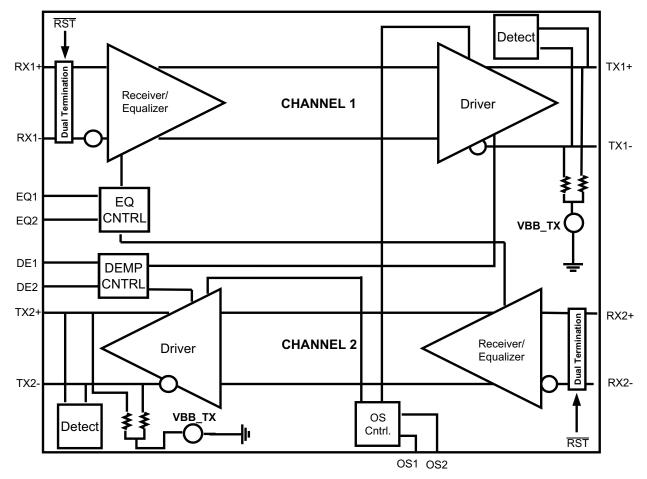
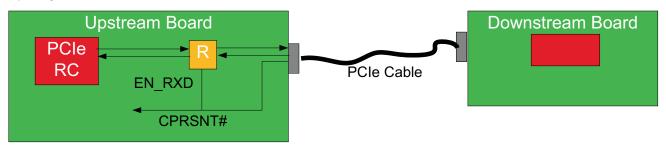


Figure 2. Data Flow Block Diagram

# **Split System**



# **Enclosed System**

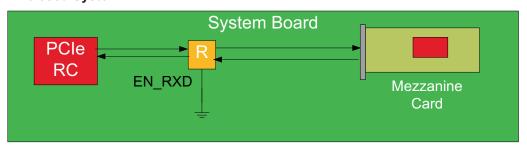


Figure 3. Typical Implementation



# **Table 1. Pin Description**

P	IN							
NUMBER NAME I/O TYPE			DESCRIPTION					
HIGH SPEED	DIFFERENTI	AL I/O PINS						
8	RX1+	I, CML						
9	RX1-	I, CML	Non-inverting and inverting CML differential input for CH 1 and CH 2. These pins are tied to an					
20	RX2+	I, CML	internal voltage bias by dual termination resistor circuit.					
19	RX2-	I, CML						
23	TX1+	O, CML						
22	TX1-	O, CML	Non-inverting and inverting CML differential output for CH 1 and CH 2. These pins are					
11	TX2+	O, CML	internally tied to voltage bias by termination resistors.					
12	TX2-	O, CML						
DEVICE CON	ITROL PIN <sup>(1)</sup>							
5	EN_RXD	I, LVCMOS	Sets device operation modes per Table 2. Internally pulled to VCC					
14	PS	I, LVCMOS	Select auto-low power save mode per Table 2. Internally pulled to GND					
7	RST	I, LVCMOS	Reset device, input active Low. Internally pulled to VCC					
24	RSVD	I, LVCMOS	Reserved for factory test. Must be connected to GND					
SIGNAL CON	ITROL PINS <sup>(2</sup>	2)						
3,16	DE1, DE2	I, LVCMOS	Selects de-emphasis settings for CH 1 and CH 2 per Table 2. Internally tied to V <sub>CC</sub> /2					
2,17	EQ1, EQ2	I, LVCMOS	Selects equalization settings for CH 1 and CH 2 per Table 2. Internally tied to V <sub>CC</sub> /2					
4, 15	OS1, OS2	I, LVCMOS	Selects output amplitude for CH 1 and CH 2 per Table 2. Internally tied to V <sub>CC</sub> /2					
POWER PINS	3	·	·					
1,13	VCC	Power	Positive supply should be 3.3V ± 10%					
6,10,18,21	GND	Power	Supply ground					

When not used can be left as NC or connected to  $V_{CC}/GND$  via  $4.7k\Omega$  resistor. Internally biased to  $V_{CC}/2$  with >200k $\Omega$  pullup/pulldown. When 3-state pins are left as NC board leakage at the pin pad must be <1  $\mu$ A otherwise drive to  $V_{CC}/2$  to assert mid-level state.

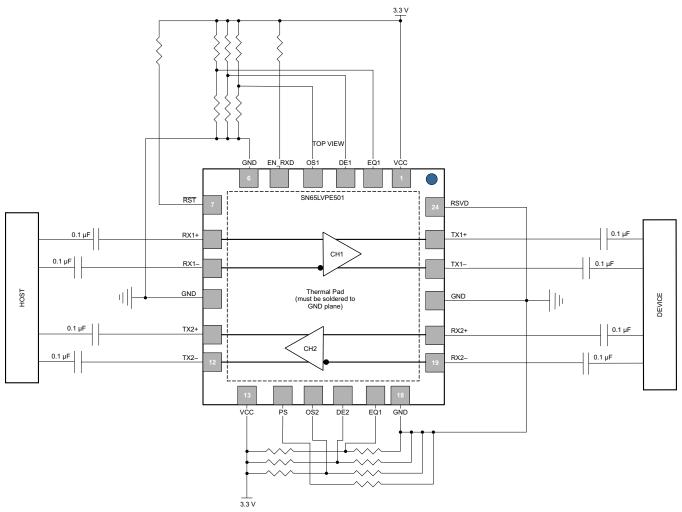


**Table 2. Signal Control Pin Setting** 

0	Sx	TRANSITION BIT AMPLITUDE (TYP mVpp)				
N	IC	1000				
(	0	87	75			
	1	11	00			
DEx <sup>(1)</sup>	OSx <sup>(1)</sup> = NC	OSx <sup>(1)</sup> = 0	OSx <sup>(1)</sup> = 1			
NC	−3.7 dB	−2.5 dB	-4.6 dB			
0	-6.4 dB	−5.5 dB	−6.6 dB			
1	−9.4 dB	−9.5 dB	−8.7 dB			
EQ	x <sup>(1)</sup>	EQUALIZA (At Geni				
N	C	(	)			
(	0	7				
	1	15				
EN_	RXD	DEVICE FUNCTION				
(	0	Set input termination to Z <sub>DC_RX</sub> and disable Rx. Detect				
	1	Perform Rx.Detect ( <b>default</b> , internally pulled to Vcc)				
R	ST	DEVICE FUNCTION				
(	0		scent state and et to Hi-Z			
	1	Device not in shut_down mode (default, internally pulled to Vcc)				
Р	S	DEVICE F	UNCTION			
	0	Auto-low power mode disabled (default, internally pulled to GND				
	1	Auto-low power mode enabled				

<sup>(1)</sup> Applies to Channel 1 and Channel 2 at 2.5 GHz.





- (1) This is a reference example and it is not intended to represent the best configuration; every designer should select the EQ and DE settings that better fits the system needs. All DEx, EQx and OSx pins default to NC.
- (2) The recommended value for all the resistors shown in the Figure is 4.9K  $\Omega$ .
- (3) For terminals OSx, DEx, and EQx, populate only pull-up or only pull-down according to the desired setting.

Figure 4. Reference Device Implementation



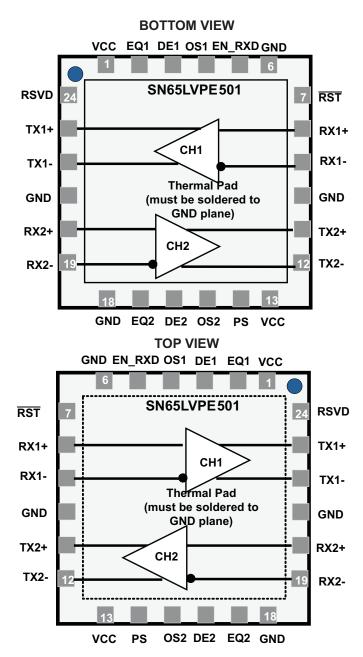


Figure 5. Flow-Through Pin-Out

# ORDERING INFORMATION(1)

PART NUMBER	PART MARKING	PCAKAGE		
SN65LVPE501RGER	LVPE501	24-pin RGE Reel (large)		
SN65LVPE501RGET	LVPE501	24-pin RGE Reel (small)		

<sup>(1)</sup> For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at www.ti.com.



#### **ABSOLUTE MAXIMUM RATINGS**

over operating free-air temperature range (unless otherwise noted)(1)

		UNIT / VALUES		
Supply Voltage Range (2)	V <sub>CC</sub>	−0.5 V to 4 V		
Voltage Pange	Differential I/O	-0.5V to 4 V		
Voltage Range	Control I/O	-0.5 V to V <sub>CC</sub> + 0.5		
	(Human Body Model) QSS 009-105 (JESD22-A114B)	±3000 V		
Electrostatic Discharge	(Charged Device Model) QSS 009-147 (JESD22-C101-A)	±1500 V		
	(Machine Model) JESD22-A115-A	±200 V		
Continuous power dissipation	See Thermal Information Table			

<sup>(1)</sup> Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### THERMAL INFORMATION

		SN65LVPE501	
	THERMAL METRIC <sup>(1)</sup>	RGE	UNITS
		24 PINS	
$\theta_{JA}$	Junction-to-ambient thermal resistance <sup>(2)</sup>	46	
$\theta_{\text{JC(TOP)}}$	Junction-to-case(top) thermal resistance (3)	42	
$\theta_{JB}$	Junction-to-board thermal resistance (4)	13	9000
Ψлт	Junction-to-top characterization parameter (5)	0.5	°C/W
ΨЈВ	Junction-to-board characterization parameter (6)	9	
$\theta_{\text{JC(BOTTOM)}}$	Junction-to-case(bottom) thermal resistance (7)	4	

- (1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.
- (2) The junction-to-ambient thermal resistance under natural convection is obtained in a simulation on a JEDEC-standard, high-K board, as specified in JESD51-7, in an environment described in JESD51-2a.
- (3) The junction-to-case (top) thermal resistance is obtained by simulating a cold plate test on the package top. No specific JEDEC-standard test exists, but a close description can be found in the ANSI SEMI standard G30-88.
- (4) The junction-to-board thermal resistance is obtained by simulating in an environment with a ring cold plate fixture to control the PCB temperature, as described in JESD51-8.
- (5) The junction-to-top characterization parameter, ψ<sub>JT</sub>, estimates the junction temperature of a device in a real system and is extracted from the simulation data for obtaining θ<sub>JA</sub>, using a procedure described in JESD51-2a (sections 6 and 7).
- (6) The junction-to-board characterization parameter, ψ<sub>JB</sub>, estimates the junction temperature of a device in a real system and is extracted from the simulation data for obtaining θ<sub>JA</sub>, using a procedure described in JESD51-2a (sections 6 and 7).

Product Folder Link(s): SN65LVPE501

(7) The junction-to-case (bottom) thermal resistance is obtained by simulating a cold plate test on the exposed (power) pad. No specific JEDEC standard test exists, but a close description can be found in the ANSI SEMI standard G30-88.

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<sup>(2)</sup> All voltage values, except differential voltages, are with respect to network ground terminal.





# **RECOMMENDED OPERATING CONDITIONS**

over operating free-air temperature range (unless otherwise noted)

		MIN	TYP	MAX	UNIT
V <sub>CC</sub>	Supply Voltage	3	3.3	3.6	V
C <sub>COUPLING</sub>	AC Coupling Capacitor	75		200	nF
	Operating free-air temperature	-40		85	°C

# **ELECTRICAL CHARACTERISTICS**

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TES	T CONDITIONS	MIN	TYP	MAX	UNIT
DEVICE PARA	METERS (under recommended opera	ating conditions, unless othe	rwise noted)				
I <sub>cc</sub>		$\overline{\text{RST}}$ , DEx, EQx, OSx = NC, E V <sub>ID</sub> = 1000mV <sub>p-p</sub>		101	120		
ICC <sub>idle</sub>	Supply Current	PS=1; When auto-low power		21	26	mA	
ICC <sub>shut-down</sub>		RST = GND		0.2	1		
ICC <sub>RX.Detect</sub>		RST, EN_RXD = NC			2		
	Maximum Data Rate					5	Gbps
AutoLP <sub>ENTRY</sub>	Auto Low Power Entry Time	Electrical Idle at Input, Refer	to Figure 9	1.0	1.3		μs
AutoLP <sub>EXIT</sub>	Auto Low Power Exit Time	After first signal activity, Refe	r to Figure 9		15	30	ns
t <sub>PU</sub>	Power Up Time	Rx Detect Start Event, Vcc = RST, EN_RXD = H	Stable		15	30	μs
t <sub>DIS</sub>	Sleep (shut-down) Mode Entry Time	RST H→L; EN_RXD=X				1	μs
T <sub>ENB</sub>	Sleep (shut-down) Mode Exit Time	RST L→H; EN_RXD=H, Star	t of Ex detect event			10	μs
CONTROL LO	GIC (under recommended operating of	conditions, unless otherwise	noted)				
V <sub>IH</sub>	High level Input Voltage			1.4		V <sub>CC</sub>	V
V <sub>IL</sub>	Low Level Input Voltage			-0.3		0.5	V
V <sub>HYS</sub>	Input Hysteresis				150		mV
		OSx, EQx, DEx = V <sub>CC</sub>				30	
I <sub>IH</sub>	High Level Input Current	$EN_RXD$ , $\overline{RST} = V_{CC}$			1	μA	
		OSx, EQx, DEx = GND	-30				
I <sub>IL</sub>	Low Level Input Current	PS = GND	-1			μΑ	
		$EN_RXD$ , $\overline{RST} = GND$	-20				
RECEIVER AC	/DC (under recommended operating	conditions, unless otherwise	e noted)				
Vin <sub>diff_pp</sub>	RX1, RX2 Input Voltage Swing	AC coupled differential signal		100		1200	mVp-p
V <sub>CM_RX</sub>	RX1, RX2 Common Mode Voltage			0		3.6	V
Vin <sub>COM_P</sub>	RX1, RX2 AC Peak common mode voltage					150	mVP
Z <sub>DC_RX</sub>	DC single ended impedance			40	50	60	Ω
Z <sub>diff_RX</sub>	DC Differential Input impedance			80	100	120	Ω
Z <sub>RX_High_IMP+</sub>	DC Input High Impedance	Device in sleep mode Rx tern respect to GND over 200mV	50	74		kΩ	
V <sub>EID_TH</sub>	Electrical Idle Detect Threshold	Measured at receiver pin (see	65	84	175	mVpp	
		50 MHz – 1.25 GHz		10			dB
RL <sub>RX-DIFF</sub>	Differential Return Loss	4.07.011 0.7.011	Operating temperature 0°C to 85°C	8			
		1.25 GHz – 2.5 GHz	Operating temperature –40°C to 85°C	7			dB
RL <sub>RX-CM</sub>	Common Mode Return Loss	50 MHz – 2.5 GHz	+	10			dB

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# **ELECTRICAL CHARACTERISTICS (continued)**

	free-air temperature range ( PARAMETER		ST CONDITIONS	MINI	TVD	MAY	UNIT
TD 4 NO				MIN	TYP	MAX	UNII
TRANSMITTER A	AC/DC (under recommended opera	1	•				
		$R_L = 100\Omega \pm 1\%$ , DEx, OS = 1	800	1000	1200		
$V_{TXDIFF\_PP}$		$R_L = 100\Omega \pm 1\%$ , DEx = NC, 0			875		mV
		$R_L = 100\Omega \pm 1\%$ , DEx = NC, 0	OSx = VCC Transition Bit		1100		
	Differential peak-to-peak Output Voltage	$R_L$ =100 $\Omega$ ±1%, DEx=NC, O Non-Transition Bit	Sx = 0,1,NC		655		
V <sub>TXDIFF_NTB_PP</sub>		$R_L$ =100 $\Omega$ ±1%, DEx=0,OSx Non-Transition Bit	= 0,1,NC		495		mV
		R <sub>L</sub> =100Ω ±1%, DEx=1, OS> NC Non-Transition Bit	ζ = 0,1,		350		
		DEx, OSx = NC, See	Operating temperature 0°C to 85°C	-3.0	-3.7	-4.0	
	De-Emphasis Level	Figure 11; (for OS1,2 = 1 and 0 see Table 2)	Operating temperature –40°C to 85°C	-3.0	-3.7	-4.2	dB
		DEx = 0, OSx = NC			-6.4		
		DEx = 1, OSx = NC			-9.4		dB
T <sub>DE</sub>	De-Emphasis Width	At 5Gbps			0.8		UI
Z <sub>diff_TX</sub>	DC Differential Impedance	Defined during signaling		80	100	120	Ω
-diii_1X	20 2o.oapodaeo	20mod damig digitamig	Operating temperature 0°C to 85°C	10		0	
		f = 50 MHz - 1.25 GHz.	Operating temperature –40°C to 85°C	9.5			
$RL_{diff\_TX}$	Differential Return Loss		Operating temperature 0°C to 85°C	6			dB
		f = 1.25 GHz - 2.5 GHz,	Operating temperature –40°C to 85°C				
DI	0 M I D I	( 50 MH 0 5 OH	Operating temperature –40°C to 85°C	5.5			
RL <sub>CM_TX</sub>	Common Mode Return Loss	f = 50 MHz – 2.5 GHz		10	00	00	dB
I <sub>TX_SC</sub>	TX short circuit current	TX± shorted to GND			60	90	mA
V <sub>TX_CM_DC</sub>	Transmitter DC common-mode voltage	Allowed DC CM voltage at T	2.1	2.65	3.1	V	
V <sub>TX_CM_AC2</sub>	TX AC common mode voltage at GEN II speed	- Max(V <sub>d+</sub> + V <sub>d-</sub> )/2 - Min(V <sub>d+</sub> -	Marky and South All South And South				mVpp
V <sub>TX_CM_AC1</sub>	TX AC common mode voltage at GEN I speed	1012A(Vd+ + Vd-)/2 - 10111(Vd+ +	• v <sub>d</sub> _//∠		2	20	mV
V <sub>TX_CM_DeltaL0-L0s</sub>	Absolute Delta DC CM voltage during active and idle states	VTX_CM_DC [L0] - VTX_CM_DC [L	<sub>.0s]</sub>  , PS=L	0		100	mV
V <sub>TX_CM-DC-Line-</sub> Delta	Absolute Delta of DC CM voltage between D+ and D-	V <sub>TX_CM_DC-D+</sub> [L0] - V <sub>TX_CM_DC</sub>	C-D- [L0]	0		25	mV
$V_{TX\_idle\_diff-AC-p}$	Electrical idle differential peak output voltage	$ V_{TX-Idle-D+} - V_{TX-Idle-D-} $ HP fil	tered to remove any DC component	0	1	10	mVpp
$V_{TX\_idle\_diff\text{-DC}}$	DC Electrical idle differential output voltage	V <sub>TX_idle-D+</sub> - V <sub>TX_idle-D-</sub>   LP fil	tered to remove any AC component		3.5		mV
V <sub>detect</sub>	Voltage change to allow receiver detect	Positive voltage to sense rec	ceiver			600	mV
$t_R, t_F$	Output Rise/Fall time	DEx = NC, OS = NC (CH 0 a at the output; VID > 1000mV	and CH 1) 20%-80% of differential voltage (pp	30	53		ps
t <sub>RF_MM</sub>	Output Rise/Fall time mismatch	DEx = NC, OS = NC (CH 0 a at the output		1	20	ps	
T <sub>diff_LH</sub> , T <sub>diff_HL</sub>	Differential Propagation Delay	DEx = NC (CH 0 and CH 1). input and output. See Figure		280	330	ps	
t <sub>idleEntry</sub> t <sub>idleExit</sub>	Idle entry and exit times	See Figure 7			4	6	ns
-	ON at GEN II Speed (under recomn	nenced operating conditions	)				
	,,	At point A in Figure 10 <sup>(2)</sup>			30	50	
T <sub>TX-TJ</sub> <sup>(1)</sup>	Total Jitter	At point B in Figure 10 <sup>(2)</sup>			25	80	ps pp
		At point A in Figure 10 <sup>(2)</sup>			16	30	

Product Folder Link(s): SN65LVPE501

<sup>(1)</sup> Includes RJ at 10<sup>-12</sup>

<sup>(2)</sup> Refer to Figure 10 with ± K28.5 pattern at 5Gbps, -3.5dB DE from source AWG.



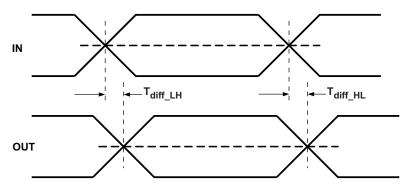


Figure 6. Propagation Delay

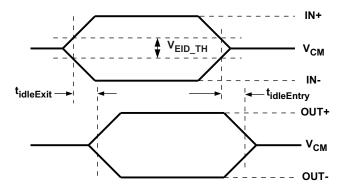


Figure 7. Idle Mode Exit and Entry Delay

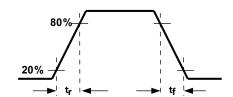


Figure 8. Output Rise and Fall Times

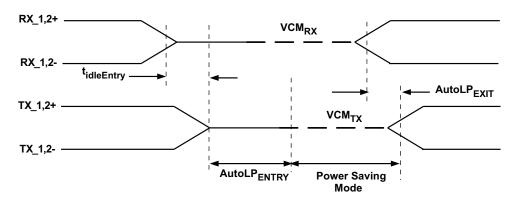


Figure 9. Auto Low Power Mode Timing (when enabled)

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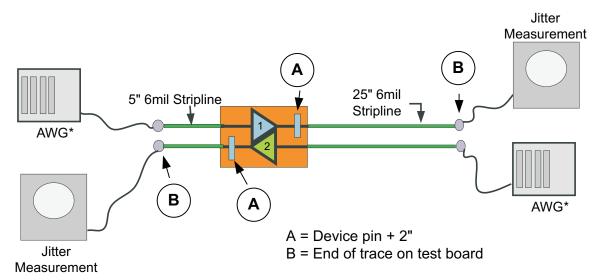


Figure 10. Jitter Measurement Setup

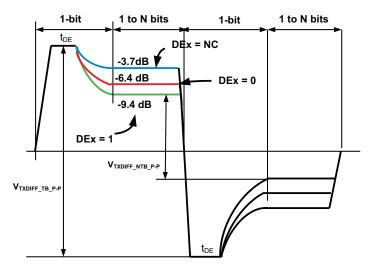


Figure 11. Output De-Emphasis Levels OSx = NC

# Typical Eye Diagram and Performance Curves at Output

Input Signal Characteristics: Data Rate = 5 Gbps,  $V_{ID}$  = 1000 mVpp, DE = -3.5 dB, Pattern = K28.5 Device Operating Conditions: VCC = 3.3 V, Temp = 25°C

Device EQ settings (EQ/DE/OS) adjusted for best eye performance



# **Output Trace Length Held Constant and Input Trace Length Varied**

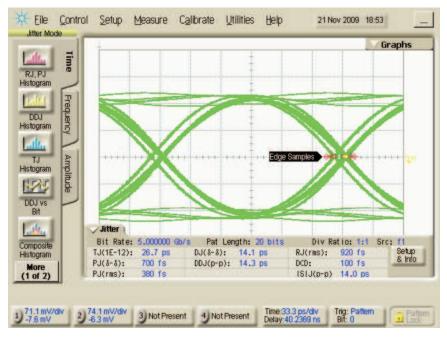


Figure 12. Input Trace = 4 Inches, 6 mil, and Measured at Output Trace = 4 Inches

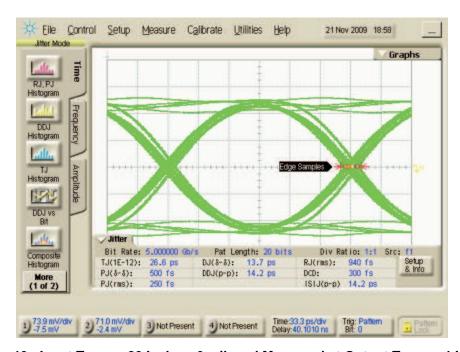


Figure 13. Input Trace = 20 Inches, 6 mil, and Measured at Output Trace = 4 Inches



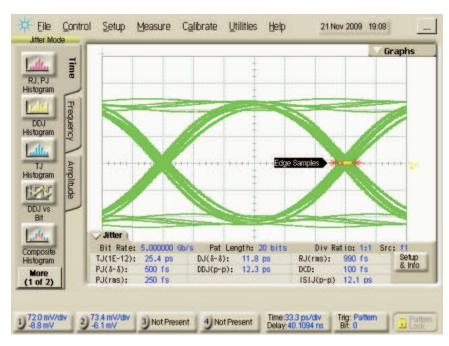


Figure 14. Input Trace = 32 Inches, 6 mil, and Measured at Output Trace = 4 Inches

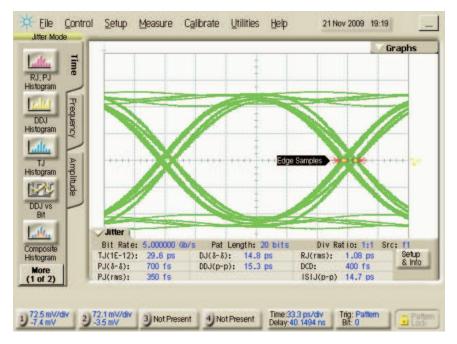


Figure 15. Input Trace = 44 Inches, 6 mil, and Measured at Output Trace = 4 Inches



# Variable Trace Lengths at Input and Output

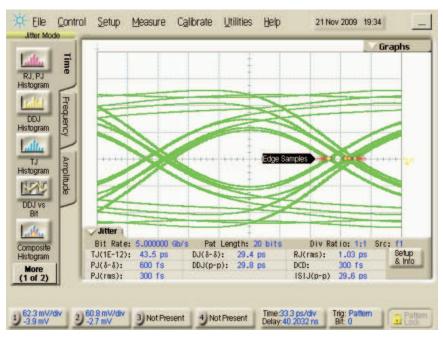


Figure 16. Input Trace = 28 Inches, 6 mil, and Measured at Output Trace = 24 Inches

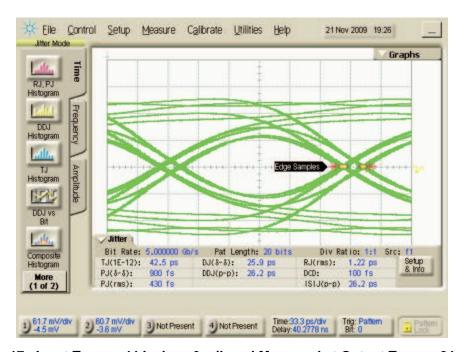


Figure 17. Input Trace = 44 Inches, 6 mil, and Measured at Output Trace = 24 Inches

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# **REVISION HISTORY**

Cł	Changes from Original (May 2010) to Revision A	Page
•	Added Figure 4	7

Product Folder Link(s): SN65LVPE501

www.ti.com 26-Apr-2025

#### PACKAGING INFORMATION

Orderable part number	Status (1)	Material type	Package   Pins	Package qty   Carrier	RoHS	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
SN65LVPE501RGER	Active	Production	VQFN (RGE)   24	3000   LARGE T&R	Yes	NIPDAU	(5) Level-2-260C-1 YEAR	-40 to 85	LVPE501
SN65LVPE501RGET	Active	Production	VQFN (RGE)   24	250   SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	LVPE501

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.



www.ti.com 3-Jun-2022

# TAPE AND REEL INFORMATION

# REEL DIMENSIONS Reel Diameter Reel Width (W1)

# TAPE DIMENSIONS KO P1 BO W Cavity A0

A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

# QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN65LVPE501RGER	VQFN	RGE	24	3000	330.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2
SN65LVPE501RGET	VQFN	RGE	24	250	180.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2



# **PACKAGE MATERIALS INFORMATION**

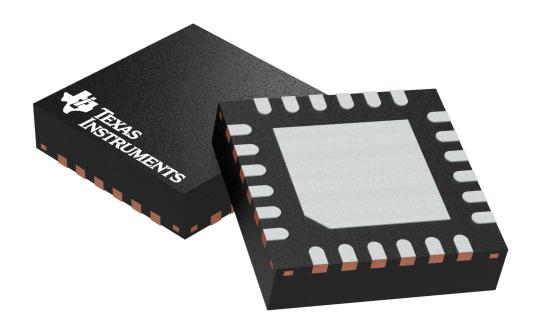
www.ti.com 3-Jun-2022



# \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN65LVPE501RGER	VQFN	RGE	24	3000	356.0	356.0	35.0
SN65LVPE501RGET	VQFN	RGE	24	250	210.0	185.0	35.0

PLASTIC QUAD FLATPACK - NO LEAD

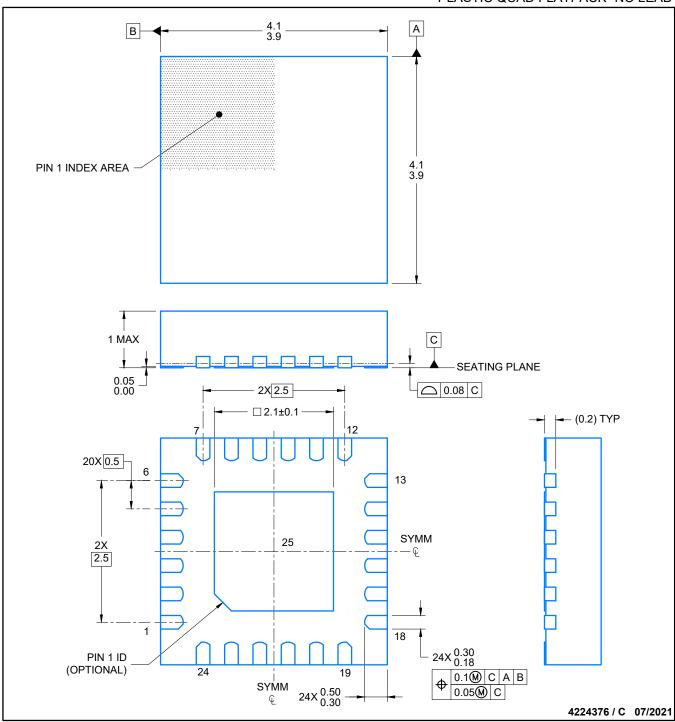


Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.

4204104/H



PLASTIC QUAD FLATPACK- NO LEAD

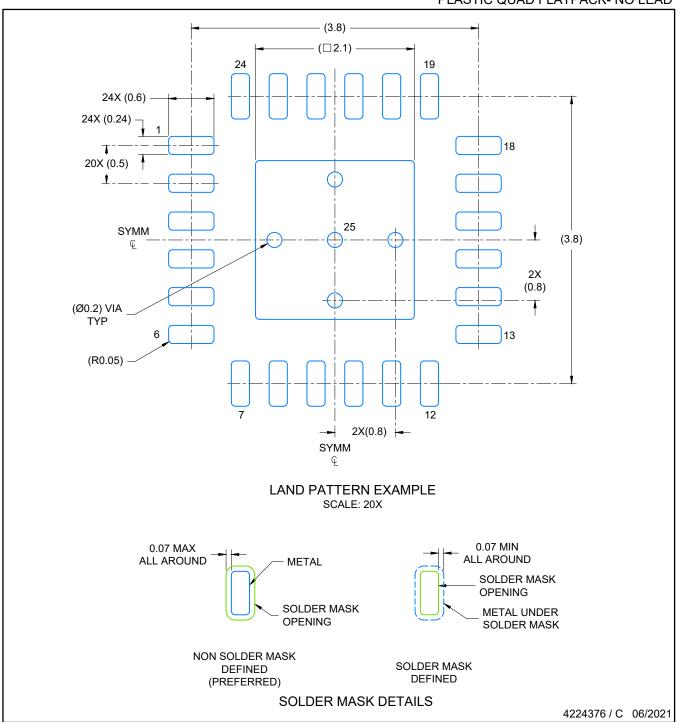


# NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.



PLASTIC QUAD FLATPACK- NO LEAD

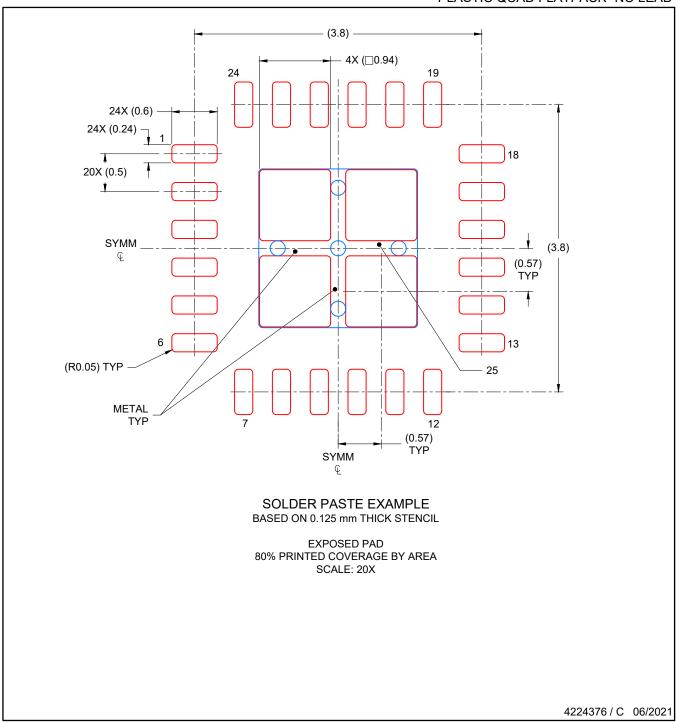


NOTES: (continued)

- This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments
  literature number SLUA271 (www.ti.com/lit/slua271).
- 5. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



PLASTIC QUAD FLATPACK- NO LEAD



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations..

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